

Preliminary datasheet**EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC / TIM****Features**

- Electrical features
 - $V_{DS} = 1200\text{ V}$
 - $I_{DN} = 75\text{ A}$ / $I_{DRM} = 150\text{ A}$
 - High current density
 - Low switching losses
- Mechanical features
 - Rugged mounting due to integrated mounting clamps
 - Integrated NTC temperature sensor
 - PressFIT contact technology
 - Pre-applied thermal interface material

**Potential applications**

- Solar applications
- Three-level applications
- DC charger for EV

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

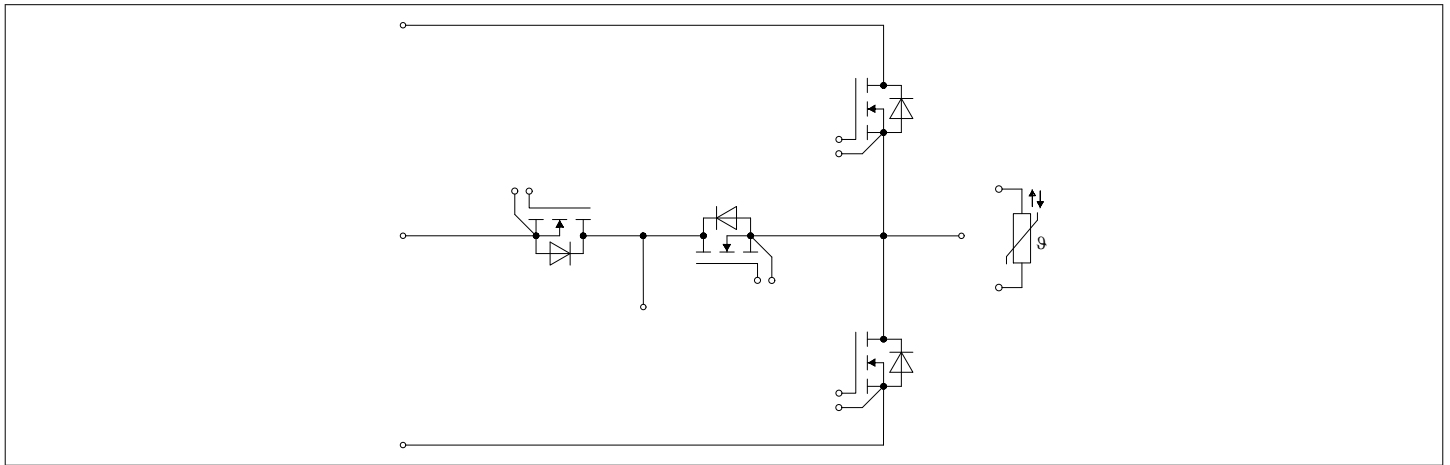
Description

Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET	3
3	Body diode	5
4	MOSFET	6
5	Body diode	8
6	NTC-Thermistor	8
7	Characteristics diagrams	9
8	Circuit diagram	19
9	Package outlines	20
10	Module label code	21
	Revision history	22
	Disclaimer	23

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Creepage distance	d_{Creep}	terminal to heatsink	11.5	mm
Creepage distance	d_{Creep}	terminal to terminal	6.3	mm
Clearance	d_{Clear}	terminal to heatsink	10.0	mm
Clearance	d_{Clear}	terminal to terminal	5.0	mm
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			21		nH
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25^\circ\text{C}$, per switch		1.5		mΩ
Storage temperature	T_{stg}		-40		125	°C
Maximum baseplate operation temperature	T_{BPmax}				125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

Storage and shipment of modules with TIM => see AN 2012-07.

Chapters 2 and 3 describe MOSFET T1/T4 and the corresponding body diode. Chapters 4 and 5 describe MOSFET T2/T3 and the corresponding body diode.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		$T_{vj} = 25^\circ\text{C}$	1200	V
Implemented drain current	I_{DN}			75	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175^\circ\text{C}$, $V_{GS} = 18 \text{ V}$	$T_H = 65^\circ\text{C}$	65	A

(table continues...)

Table 3 (continued) Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by $T_{vj\text{max}}$	150	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	V_{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{\text{GS(on)}}$		15...18	V
Off-state gate voltage	$V_{\text{GS(off)}}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source on-resistance	$R_{\text{DS(on)}}$	$I_{\text{D}} = 75 \text{ A}$	$V_{\text{GS}}=18 \text{ V}, T_{vj}=25 \text{ °C}$		10.8	16	mΩ
			$V_{\text{GS}}=18 \text{ V}, T_{vj}=125 \text{ °C}$		17.4		
			$V_{\text{GS}}=18 \text{ V}, T_{vj}=175 \text{ °C}$		23.1		
			$V_{\text{GS}}=15 \text{ V}, T_{vj}=25 \text{ °C}$		12.9		
Gate threshold voltage	$V_{\text{GS(th)}}$	$I_{\text{D}} = 30 \text{ mA}, V_{\text{DS}} = V_{\text{GS}}, T_{vj} = 25 \text{ °C},$ (tested after 1ms pulse at $V_{\text{GS}} = +20 \text{ V}$)		3.45	4.3	5.15	V
Total gate charge	Q_{G}	$V_{\text{DS}}=800 \text{ V}, V_{\text{GS}} = -3/18 \text{ V}$			0.223		μC
Internal gate resistor	R_{Gint}	$T_{vj}=25 \text{ °C}$			2.7		Ω
Input capacitance	C_{ISS}	$f = 100 \text{ kHz}, V_{\text{DS}}=800 \text{ V}, V_{\text{GS}}=0 \text{ V}$	$T_{vj}=25 \text{ °C}$		6.6		nF
Output capacitance	C_{OSS}	$f = 100 \text{ kHz}, V_{\text{DS}}=800 \text{ V}, V_{\text{GS}}=0 \text{ V}$	$T_{vj}=25 \text{ °C}$		0.315		nF
Reverse transfer capacitance	C_{rSS}	$f = 100 \text{ kHz}, V_{\text{DS}}=800 \text{ V}, V_{\text{GS}}=0 \text{ V}$	$T_{vj}=25 \text{ °C}$		0.021		nF
C_{OSS} stored energy	E_{OSS}	$V_{\text{DS}}=800 \text{ V}, V_{\text{GS}} = -3/18 \text{ V}, T_{vj}=25 \text{ °C}$			129		μJ
Drain-source leakage current	I_{DSS}	$V_{\text{DS}}=1200 \text{ V}, V_{\text{GS}}=-3 \text{ V}$	$T_{vj}=25 \text{ °C}$		0.045	300	μA
Gate-source leakage current	I_{GSS}	$V_{\text{DS}} = 0 \text{ V}, T_{vj}=25 \text{ °C}$	$V_{\text{GS}}=20 \text{ V}$			400	nA

(table continues...)

Table 5 (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 75\ A, R_{Gon} = 4.3\ \Omega,$ $V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	34		ns
			$T_{vj} = 125\ ^\circ C$	34		
			$T_{vj} = 175\ ^\circ C$	34		
Rise time (inductive load)	t_r	$I_D = 75\ A, R_{Gon} = 4.3\ \Omega,$ $V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	37		ns
			$T_{vj} = 125\ ^\circ C$	40		
			$T_{vj} = 175\ ^\circ C$	41		
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 75\ A, R_{Goff} = 2.4\ \Omega,$ $V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	61		ns
			$T_{vj} = 125\ ^\circ C$	66		
			$T_{vj} = 175\ ^\circ C$	69		
Fall time (inductive load)	t_f	$I_D = 75\ A, R_{Goff} = 2.4\ \Omega,$ $V_{DS} = 400\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	12.5		ns
			$T_{vj} = 125\ ^\circ C$	12.5		
			$T_{vj} = 175\ ^\circ C$	12.5		
Turn-on energy loss per pulse	E_{on}	$I_D = 75\ A, V_{DS} = 400\ V,$ $L_\sigma = 35\ nH, V_{GS} = -3/18\ V,$ $R_{Gon} = 4.3\ \Omega, di/dt = 4.09$ $kA/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.582		mJ
			$T_{vj} = 125\ ^\circ C$	0.635		
			$T_{vj} = 175\ ^\circ C$	0.659		
Turn-off energy loss per pulse	E_{off}	$I_D = 75\ A, V_{DS} = 400\ V,$ $L_\sigma = 35\ nH, V_{GS} = -3/18\ V,$ $R_{Goff} = 2.4\ \Omega, dv/dt = 25.6$ $kV/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.154		mJ
			$T_{vj} = 125\ ^\circ C$	0.155		
			$T_{vj} = 175\ ^\circ C$	0.155		
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, Valid with IFX pre-applied Thermal Interface Material			0.758	K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	$^\circ C$

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150^\circ C$ is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

3 Body diode

Table 6 **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V$ $T_H = 65\ ^\circ C$	24	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 75 \text{ A}$, $V_{GS} = -3 \text{ V}$	$T_{vj}=25 \text{ °C}$		4.2	5.35	V
			$T_{vj}=125 \text{ °C}$		3.9		
			$T_{vj}=175 \text{ °C}$		3.8		

4 MOSFET

Table 8 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		$T_{vj} = 25 \text{ °C}$	1200	V
Implemented drain current	I_{DN}			75	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	$T_H = 65 \text{ °C}$	55	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}		150	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$		-10/23	V
Gate-source voltage, max. static voltage	V_{GS}			-7/20	V

Table 9 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 10 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 75 \text{ A}$	$V_{GS}=18 \text{ V}$, $T_{vj}=25 \text{ °C}$		10.8	16	mΩ
			$V_{GS}=18 \text{ V}$, $T_{vj}=125 \text{ °C}$		17.4		
			$V_{GS}=18 \text{ V}$, $T_{vj}=175 \text{ °C}$		23.1		
			$V_{GS}=15 \text{ V}$, $T_{vj}=25 \text{ °C}$		12.9		
Gate threshold voltage	$V_{GS(th)}$	$I_D = 30 \text{ mA}$, $V_{DS} = V_{GS}$, $T_{vj} = 25 \text{ °C}$, (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$)		3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DS}=800 \text{ V}$, $V_{GS} = -3/18 \text{ V}$			0.223		μC

(table continues...)

Table 10 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Internal gate resistor	R_{Gint}	$T_{vj}=25\text{ °C}$		2.7		Ω
Input capacitance	C_{ISS}	$f = 100\text{ kHz}$, $V_{DS}=800\text{ V}$, $V_{GS}=0\text{ V}$ $T_{vj}=25\text{ °C}$		6.6		nF
Output capacitance	C_{OSS}	$f = 100\text{ kHz}$, $V_{DS}=800\text{ V}$, $V_{GS}=0\text{ V}$ $T_{vj}=25\text{ °C}$		0.315		nF
Reverse transfer capacitance	C_{rss}	$f = 100\text{ kHz}$, $V_{DS}=800\text{ V}$, $V_{GS}=0\text{ V}$ $T_{vj}=25\text{ °C}$		0.021		nF
C_{OSS} stored energy	E_{OSS}	$V_{DS}=800\text{ V}$, $V_{GS} = -3/18\text{ V}$, $T_{vj}=25\text{ °C}$		129		μJ
Drain-source leakage current	I_{DSS}	$V_{DS}=1200\text{ V}$, $V_{GS}=-3\text{ V}$ $T_{vj}=25\text{ °C}$		0.045	300	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0\text{ V}$, $T_{vj}=25\text{ °C}$ $V_{GS}=20\text{ V}$			400	nA
Turn-on delay time (inductive load)	t_{don}	$I_D = 75\text{ A}$, $R_{Gon} = 4.3\text{ }\Omega$, $V_{DS} = 400\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	34		ns
			$T_{vj} = 125\text{ °C}$	34		
			$T_{vj} = 175\text{ °C}$	34		
Rise time (inductive load)	t_r	$I_D = 75\text{ A}$, $R_{Gon} = 4.3\text{ }\Omega$, $V_{DS} = 400\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	43		ns
			$T_{vj} = 125\text{ °C}$	46		
			$T_{vj} = 175\text{ °C}$	47		
Turn-off delay time (inductive load)	t_{doff}	$I_D = 75\text{ A}$, $R_{Goff} = 2.4\text{ }\Omega$, $V_{DS} = 400\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	60		ns
			$T_{vj} = 125\text{ °C}$	65		
			$T_{vj} = 175\text{ °C}$	68		
Fall time (inductive load)	t_f	$I_D = 75\text{ A}$, $R_{Goff} = 2.4\text{ }\Omega$, $V_{DS} = 400\text{ V}$, $V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$	12.6		ns
			$T_{vj} = 125\text{ °C}$	12.6		
			$T_{vj} = 175\text{ °C}$	12.6		
Turn-on energy loss per pulse	E_{on}	$I_D = 75\text{ A}$, $V_{DS} = 400\text{ V}$, $L_\sigma = 35\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon} = 4.3\text{ }\Omega$, $di/dt = 4.11\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$)	$T_{vj} = 25\text{ °C}$	0.586		mJ
			$T_{vj} = 125\text{ °C}$	0.642		
			$T_{vj} = 175\text{ °C}$	0.679		
Turn-off energy loss per pulse	E_{off}	$I_D = 75\text{ A}$, $V_{DS} = 400\text{ V}$, $L_\sigma = 35\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Goff} = 2.4\text{ }\Omega$, $dv/dt = 25.4\text{ kV}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$)	$T_{vj} = 25\text{ °C}$	0.168		mJ
			$T_{vj} = 125\text{ °C}$	0.174		
			$T_{vj} = 175\text{ °C}$	0.177		
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, Valid with IFX pre-applied Thermal Interface Material			0.998	K/W
Temperature under switching conditions	T_{vjop}		-40		175	$^{\circ}\text{C}$

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150^{\circ}\text{C}$ is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

5 Body diode

Table 11 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175^{\circ}\text{C}$, $V_{GS} = -3\text{ V}$	$T_H = 65^{\circ}\text{C}$	24	A

Table 12 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 75\text{ A}$, $V_{GS} = -3\text{ V}$	$T_{vj} = 25^{\circ}\text{C}$		4.2	5.35	V
			$T_{vj} = 125^{\circ}\text{C}$		3.9		
			$T_{vj} = 175^{\circ}\text{C}$		3.8		

6 NTC-Thermistor

Table 13 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25^{\circ}\text{C}$		5		kΩ
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100^{\circ}\text{C}$, $R_{100} = 493\ \Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25^{\circ}\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15\text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15\text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15\text{ K}))]$		3433		K

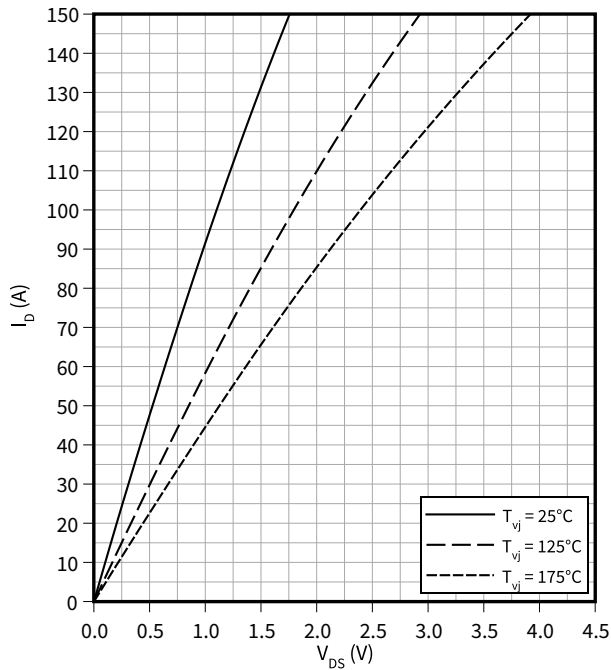
Note: Specification according to the valid application note.

7 Characteristics diagrams

Output characteristic (typical), MOSFET, T1 / T4

$I_D = f(V_{DS})$

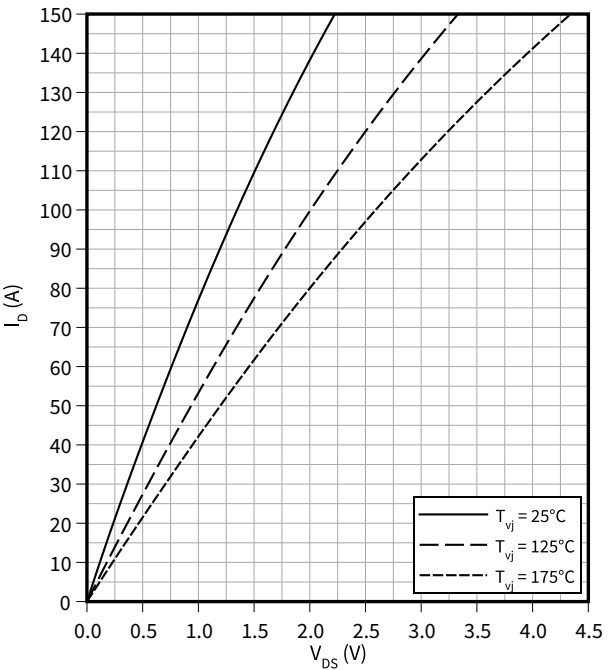
$V_{GS} = 18\text{ V}$



Output characteristic (typical), MOSFET, T1 / T4

$I_D = f(V_{DS})$

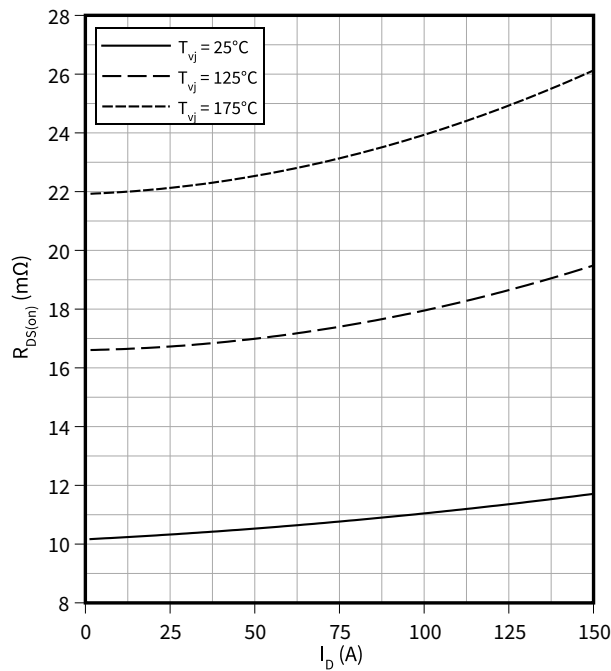
$V_{GS} = 15\text{ V}$



Drain source on-resistance (typical), MOSFET, T1 / T4

$R_{DS(on)} = f(I_D)$

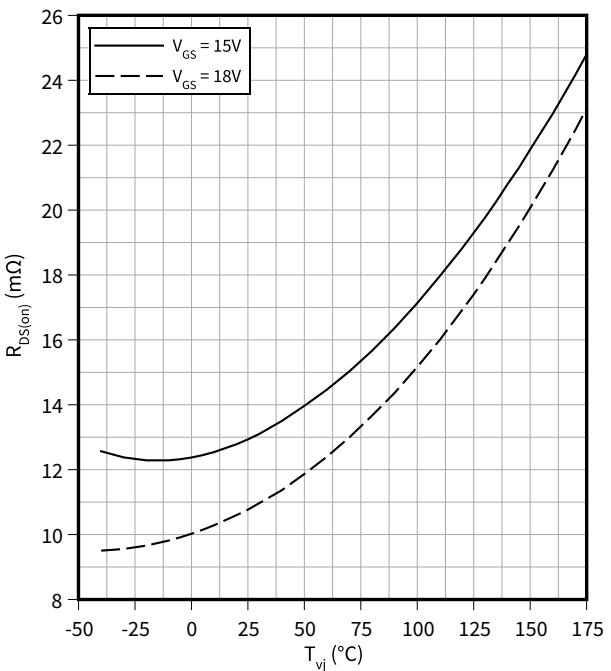
$V_{GS} = 18\text{ V}$



Drain source on-resistance (typical), MOSFET, T1 / T4

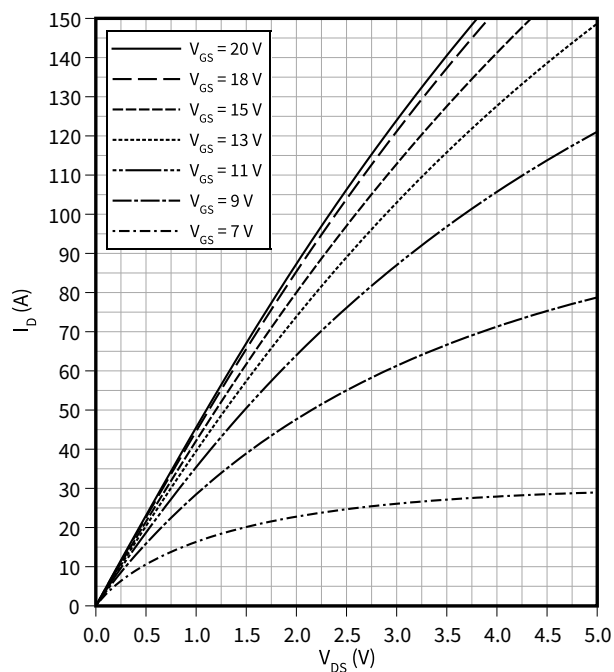
$R_{DS(on)} = f(T_{vj})$

$I_D = 75\text{ A}$



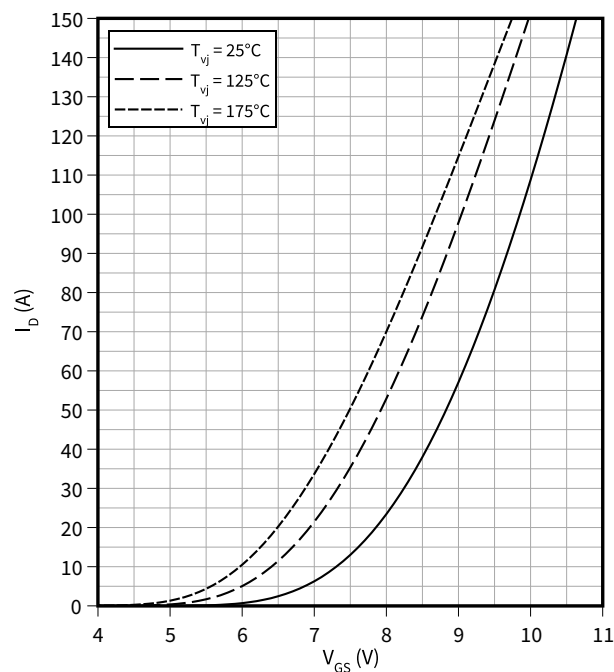
Output characteristic field (typical), MOSFET, T1 / T4

$I_D = f(V_{DS})$
 $T_{vj} = 175\text{ °C}$



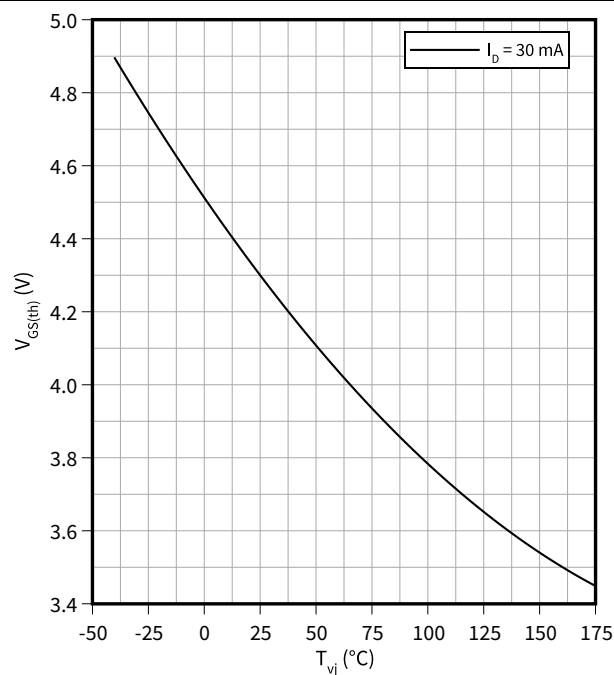
Transfer characteristic (typical), MOSFET, T1 / T4

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



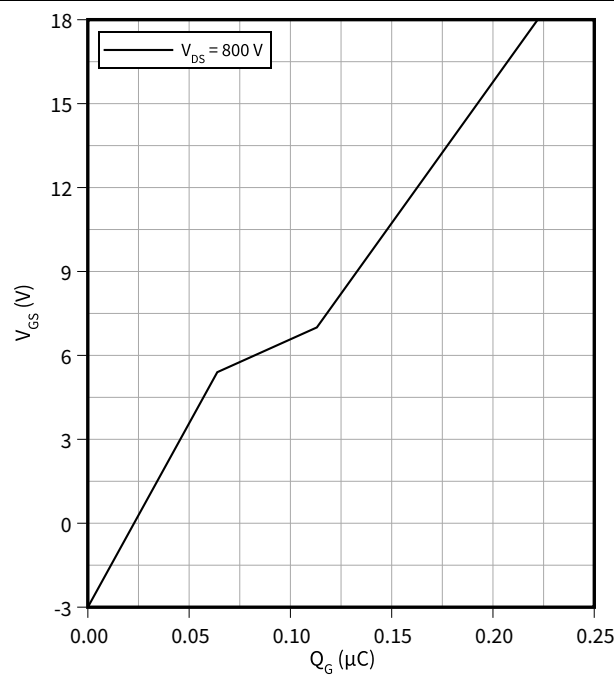
Gate-source threshold voltage (typical), MOSFET, T1 / T4

$V_{GS(th)} = f(T_{vj})$
 $V_{GS} = V_{DS}$



Gate charge characteristic (typical), MOSFET, T1 / T4

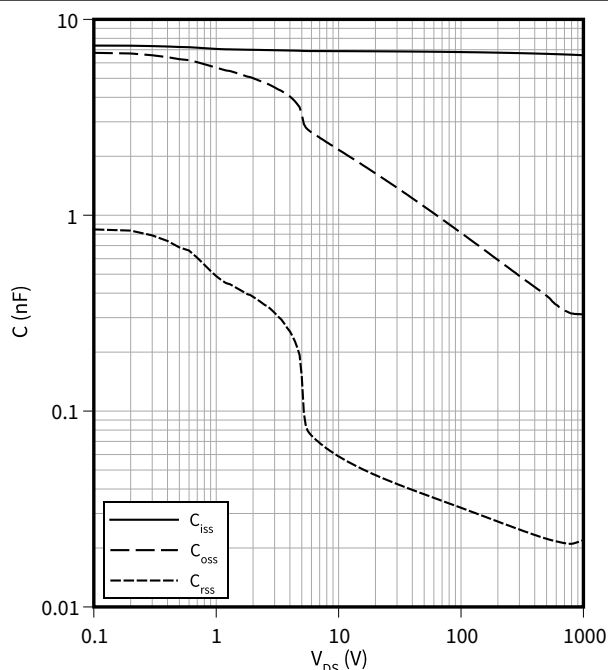
$V_{GS} = f(Q_G)$
 $I_D = 75\text{ A}, T_{vj} = 25\text{ °C}$



Capacity characteristic (typical), MOSFET, T1 / T4

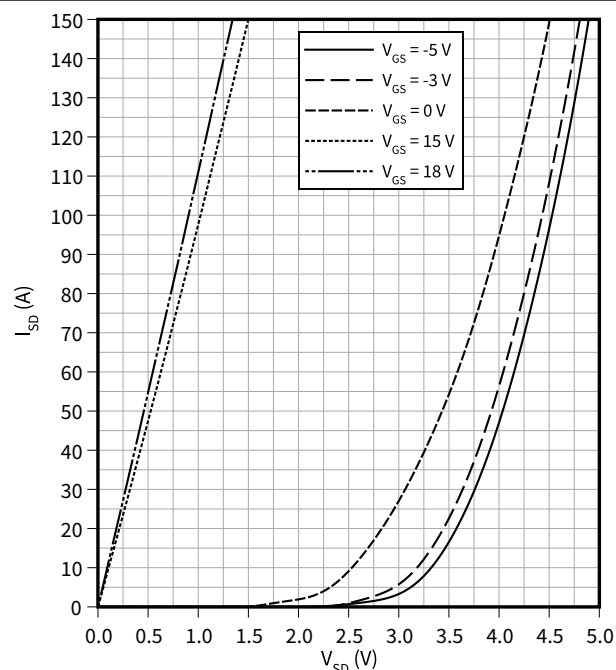
$$C = f(V_{DS})$$

$$f = 100 \text{ kHz}, T_{vj} = 25^\circ\text{C}, V_{GS} = 0 \text{ V}$$

**Forward characteristic body diode (typical), MOSFET, T1 / T4**

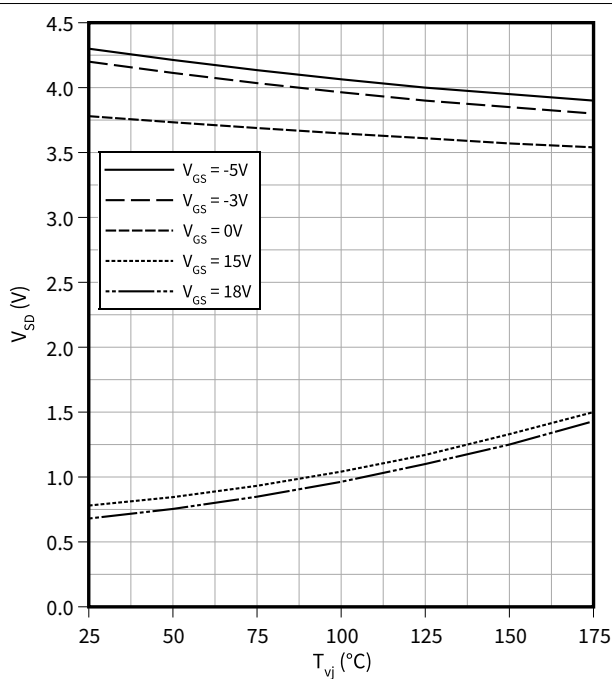
$$I_{SD} = f(V_{SD})$$

$$T_{vj} = 25^\circ\text{C}$$

**Forward voltage of body diode (typical), MOSFET, T1 / T4**

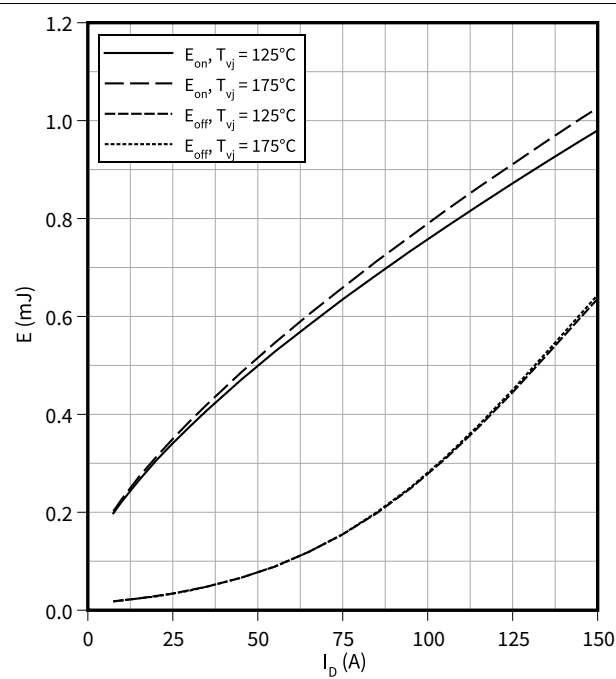
$$V_{SD} = f(T_{vj})$$

$$I_{SD} = 75 \text{ A}$$

**Switching losses (typical), MOSFET, T1 / T4**

$$E = f(I_D)$$

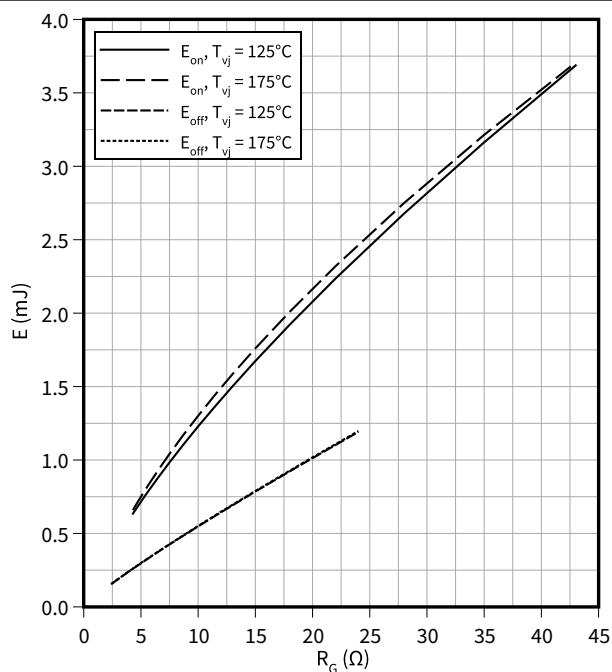
$$R_{Goff} = 2.4 \Omega, R_{Gon} = 4.3 \Omega, V_{DS} = 400 \text{ V}, V_{GS} = -3/18 \text{ V}$$



Switching losses (typical), MOSFET, T1 / T4

$$E = f(R_G)$$

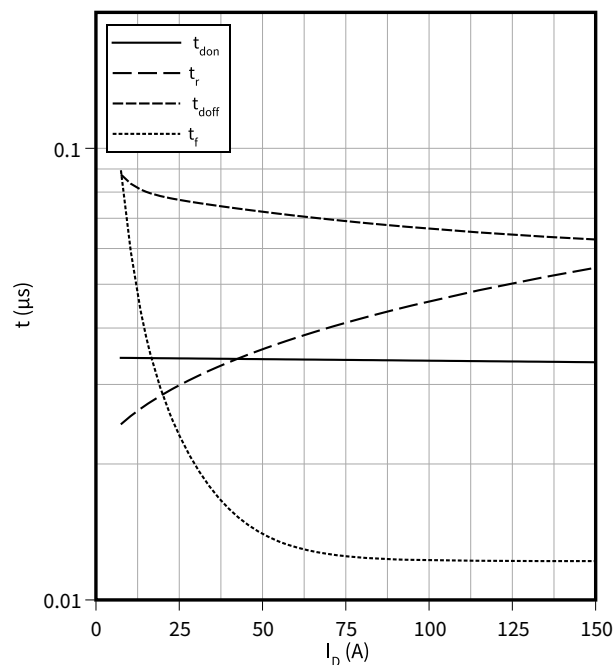
$V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $V_{GS} = -3/18 \text{ V}$



Switching times (typical), MOSFET, T1 / T4

$$t = f(I_D)$$

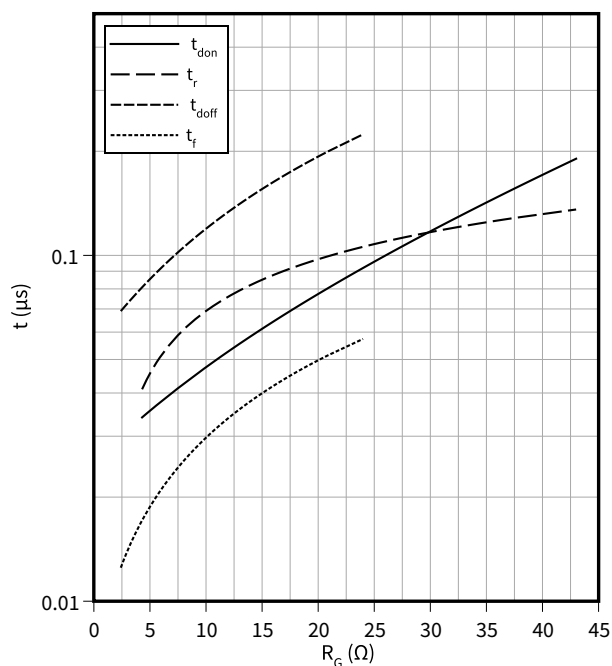
$R_{Goff} = 2.4 \text{ } \Omega$, $R_{Gon} = 4.3 \text{ } \Omega$, $V_{DS} = 400 \text{ V}$, $T_{vj} = 175 \text{ } ^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



Switching times (typical), MOSFET, T1 / T4

$$t = f(R_G)$$

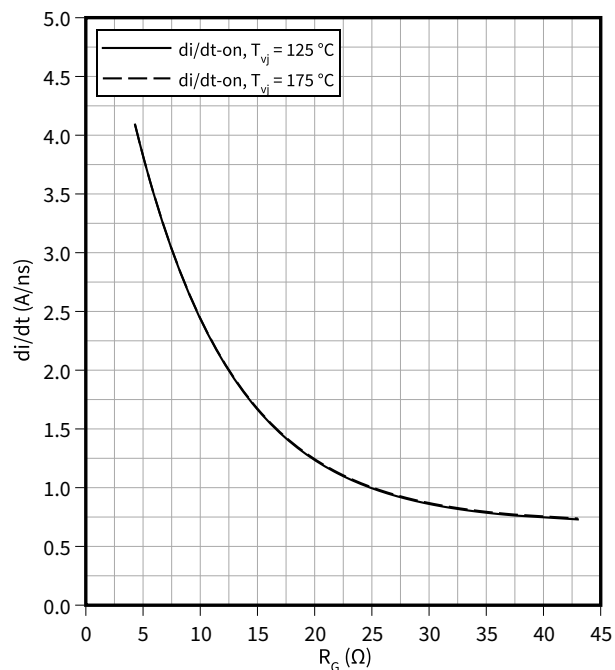
$V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $T_{vj} = 175 \text{ } ^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



Current slope (typical), MOSFET, T1 / T4

$$di/dt = f(R_G)$$

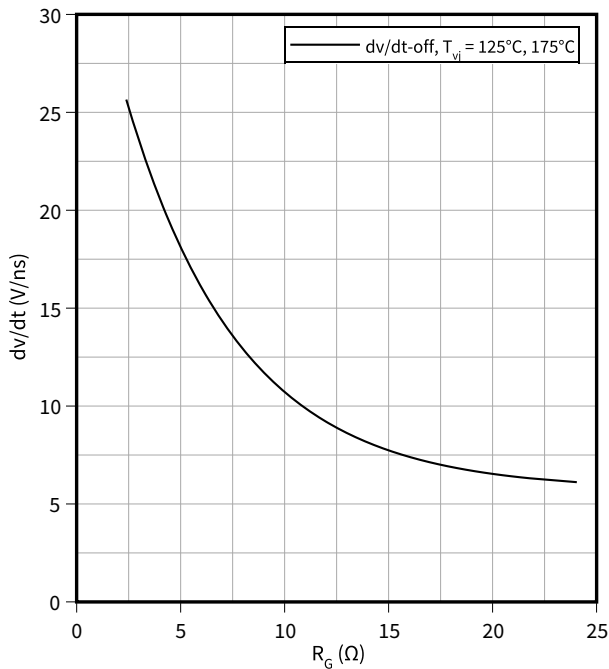
$V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $V_{GS} = -3/18 \text{ V}$



7 Characteristics diagrams

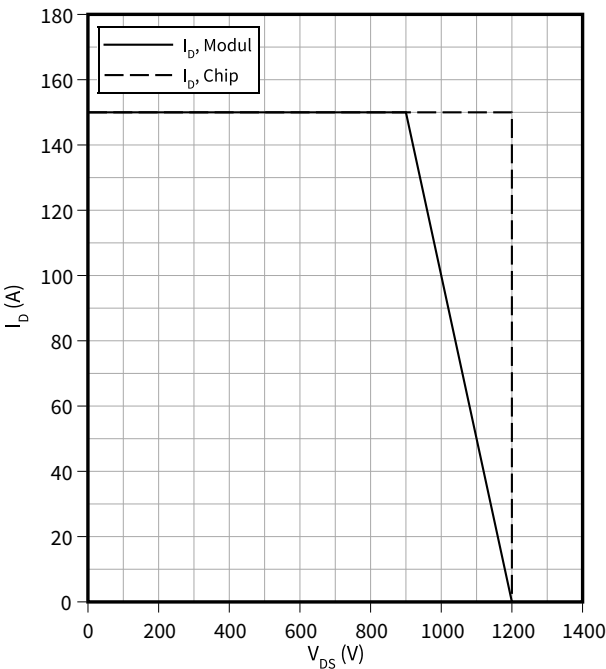
Voltage slope (typical), MOSFET, T1 / T4

$dv/dt = f(R_G)$
 $V_{DS} = 400\text{ V}$, $I_D = 75\text{ A}$, $V_{GS} = -3/18\text{ V}$



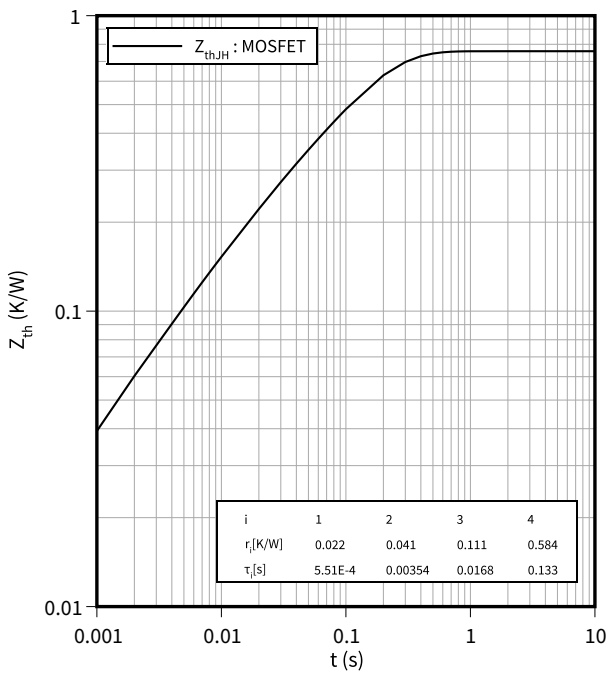
Reverse bias safe operating area (RBSOA), MOSFET, T1 / T4

$I_D = f(V_{DS})$
 $R_{Goff} = 2.4\ \Omega$, $T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



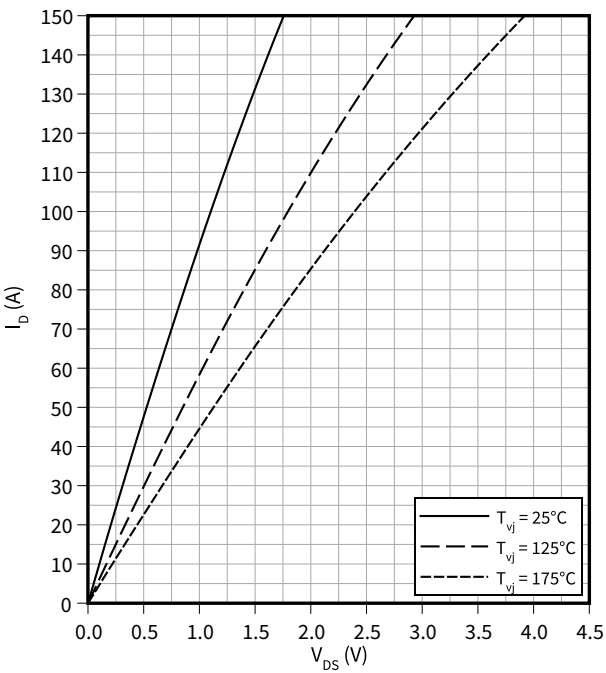
Transient thermal impedance, MOSFET, T1 / T4

$Z_{th} = f(t)$



Output characteristic (typical), MOSFET, T2 / T3

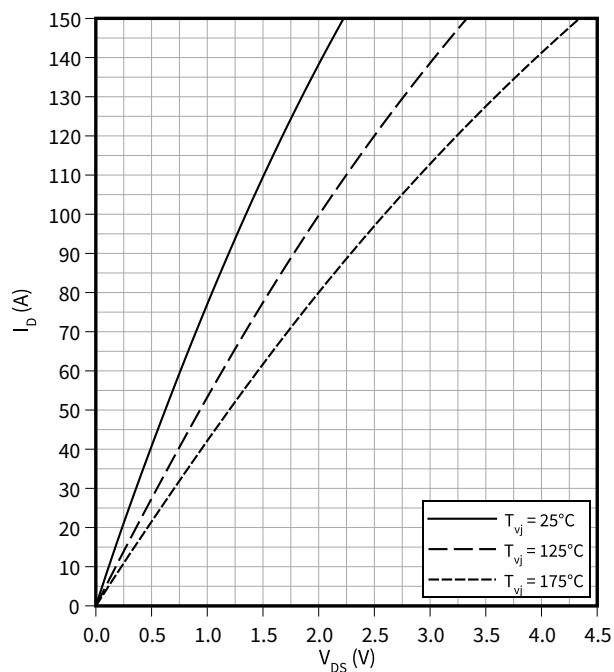
$I_D = f(V_{DS})$
 $V_{GS} = 18\text{ V}$



Output characteristic (typical), MOSFET, T2 / T3

$$I_D = f(V_{DS})$$

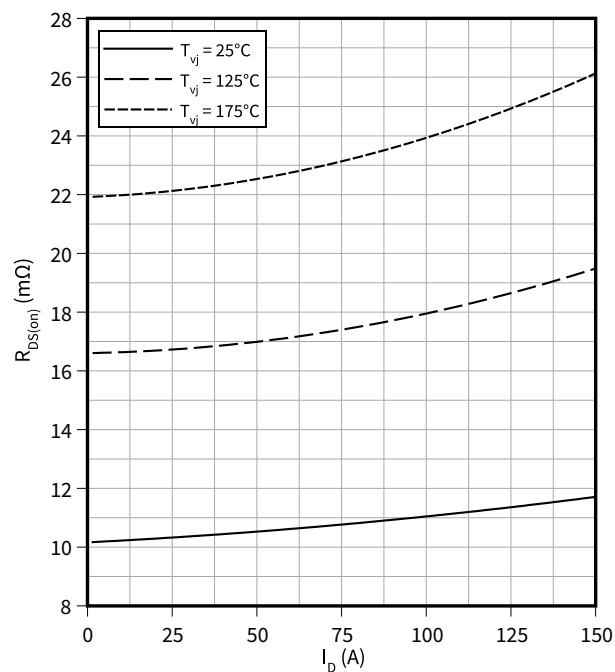
$$V_{GS} = 15 \text{ V}$$



Drain source on-resistance (typical), MOSFET, T2 / T3

$$R_{DS(on)} = f(I_D)$$

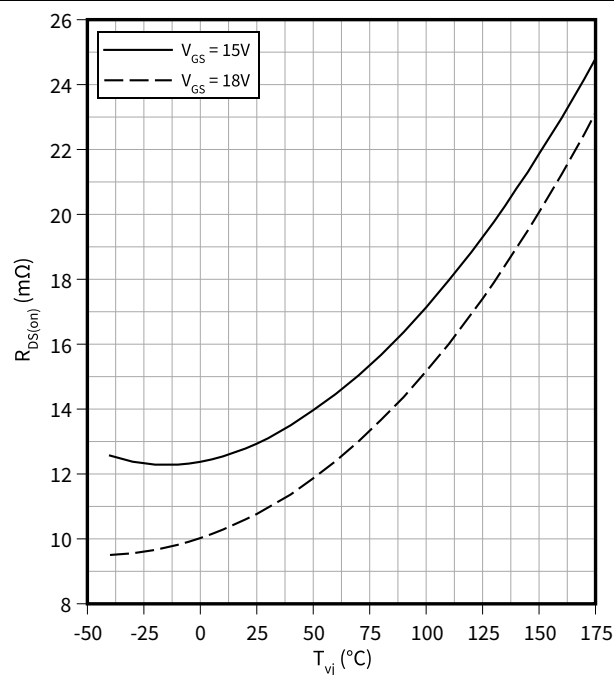
$$V_{GS} = 18 \text{ V}$$



Drain source on-resistance (typical), MOSFET, T2 / T3

$$R_{DS(on)} = f(T_{vj})$$

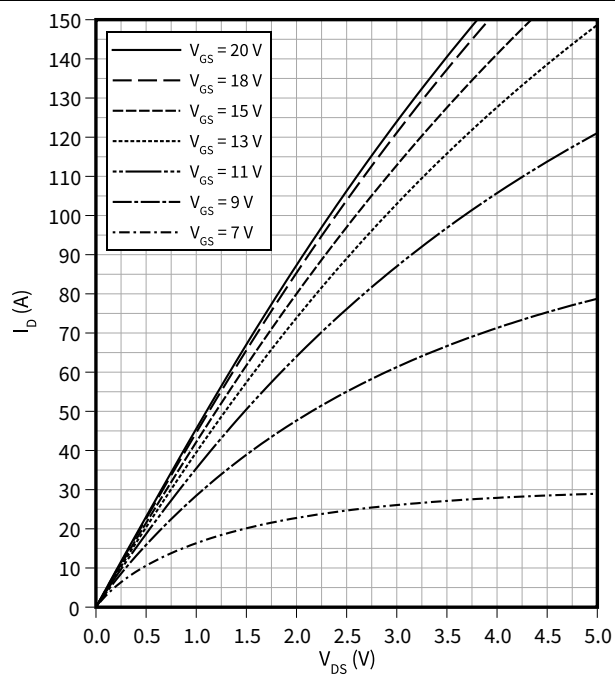
$$I_D = 75 \text{ A}$$



Output characteristic field (typical), MOSFET, T2 / T3

$$I_D = f(V_{DS})$$

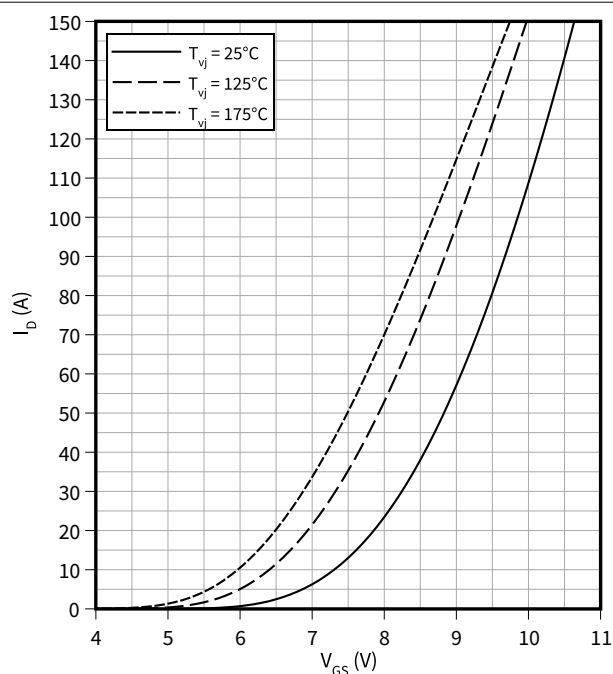
$$T_{vj} = 175 \text{ °C}$$



Transfer characteristic (typical), MOSFET, T2 / T3

$$I_D = f(V_{GS})$$

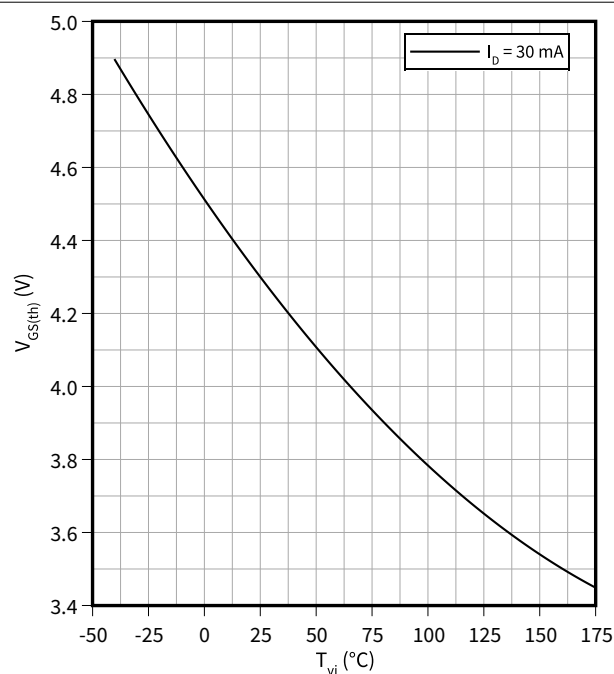
$$V_{DS} = 20 \text{ V}$$



Gate-source threshold voltage (typical), MOSFET, T2 / T3

$$V_{GS(th)} = f(T_{vj})$$

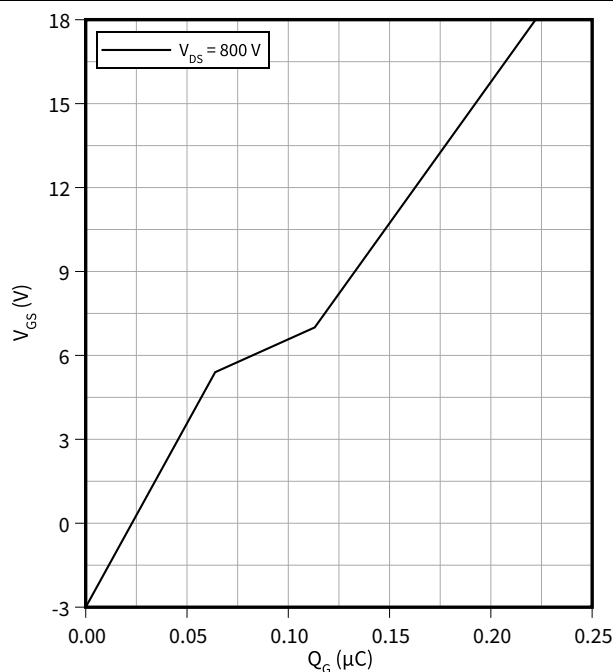
$$V_{GS} = V_{DS}$$



Gate charge characteristic (typical), MOSFET, T2 / T3

$$V_{GS} = f(Q_G)$$

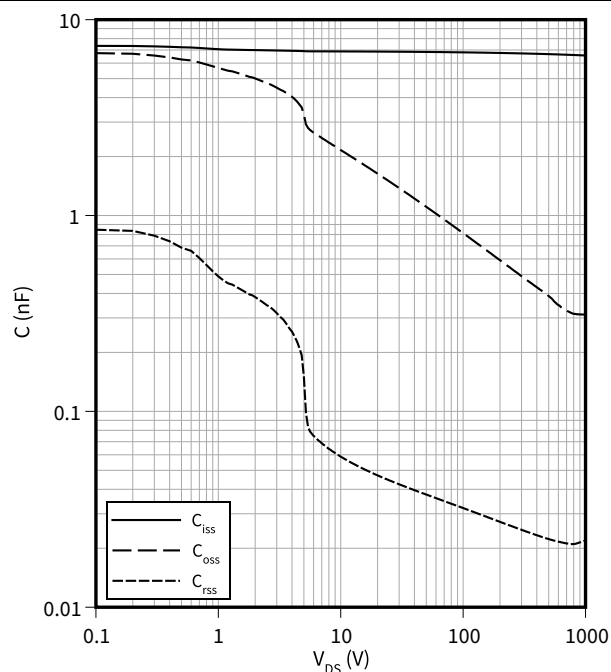
$$I_D = 75 \text{ A}, T_{vj} = 25^\circ\text{C}$$



Capacity characteristic (typical), MOSFET, T2 / T3

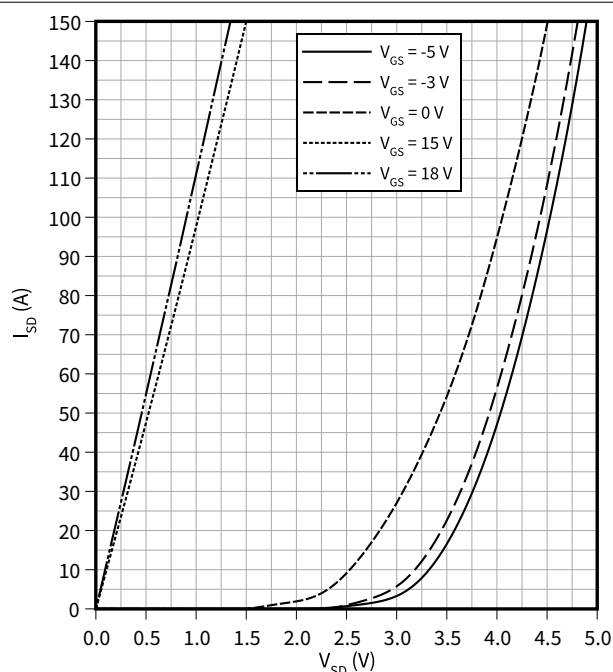
$$C = f(V_{DS})$$

$$f = 100 \text{ kHz}, T_{vj} = 25^\circ\text{C}, V_{GS} = 0 \text{ V}$$



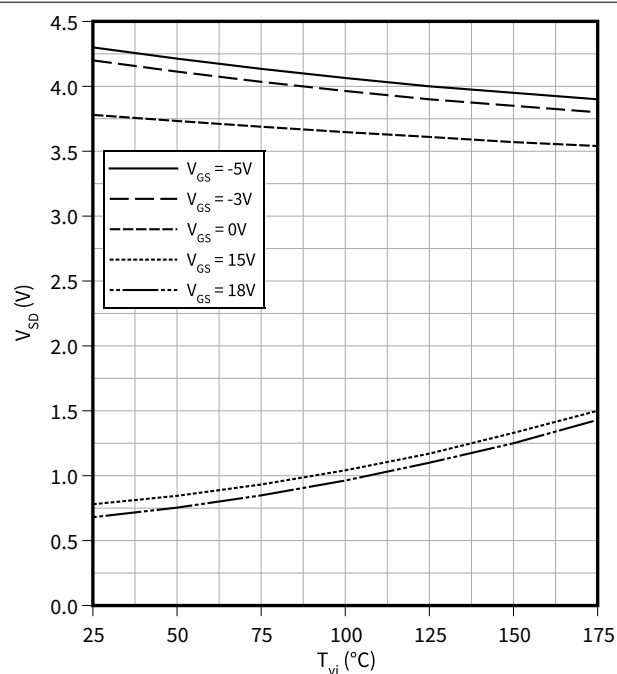
Forward characteristic body diode (typical), MOSFET, T2 / T3

$I_{SD} = f(V_{SD})$
 $T_{vj} = 25\text{ °C}$



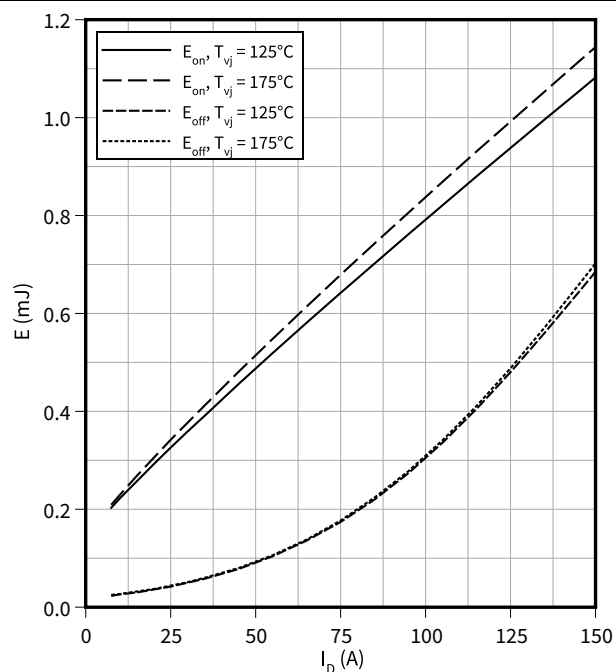
Forward voltage of body diode (typical), MOSFET, T2 / T3

$V_{SD} = f(T_{vj})$
 $I_{SD} = 75\text{ A}$



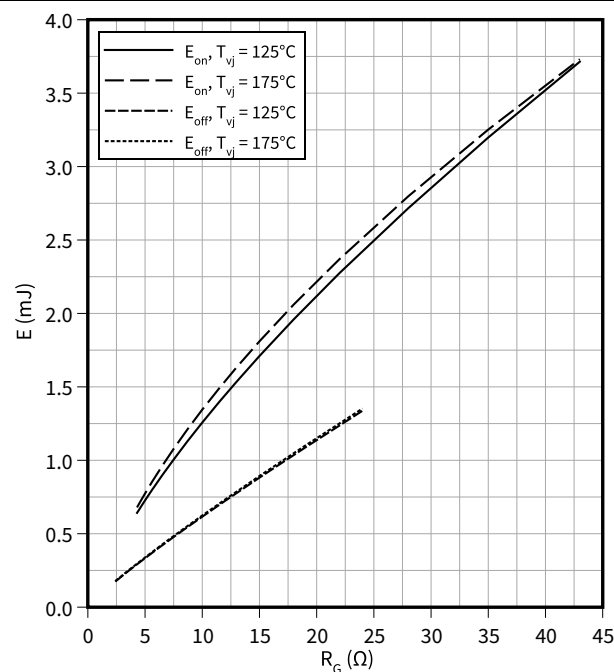
Switching losses (typical), MOSFET, T2 / T3

$E = f(I_D)$
 $R_{Goff} = 2.4\text{ }\Omega$, $R_{Gon} = 4.3\text{ }\Omega$, $V_{DS} = 400\text{ V}$, $V_{GS} = -3/18\text{ V}$



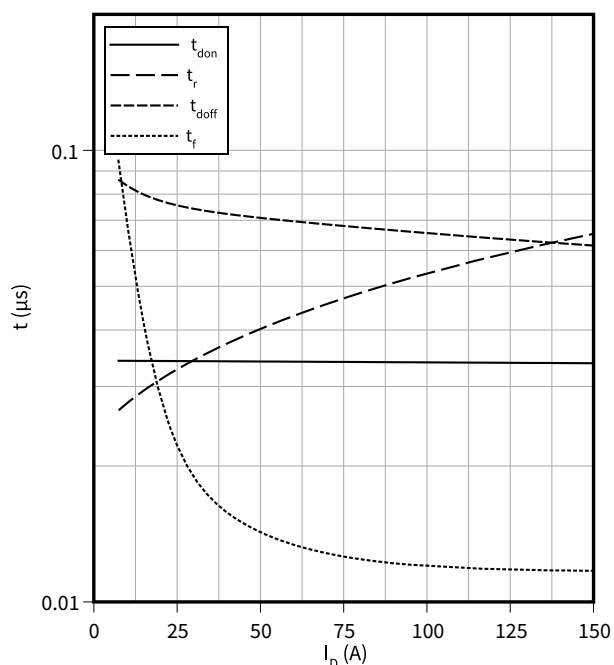
Switching losses (typical), MOSFET, T2 / T3

$E = f(R_G)$
 $V_{DS} = 400\text{ V}$, $I_D = 75\text{ A}$, $V_{GS} = -3/18\text{ V}$

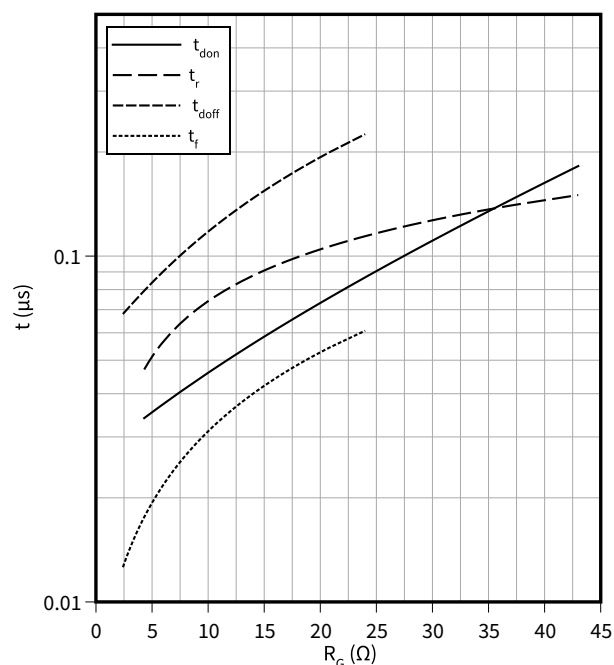


Switching times (typical), MOSFET, T2 / T3

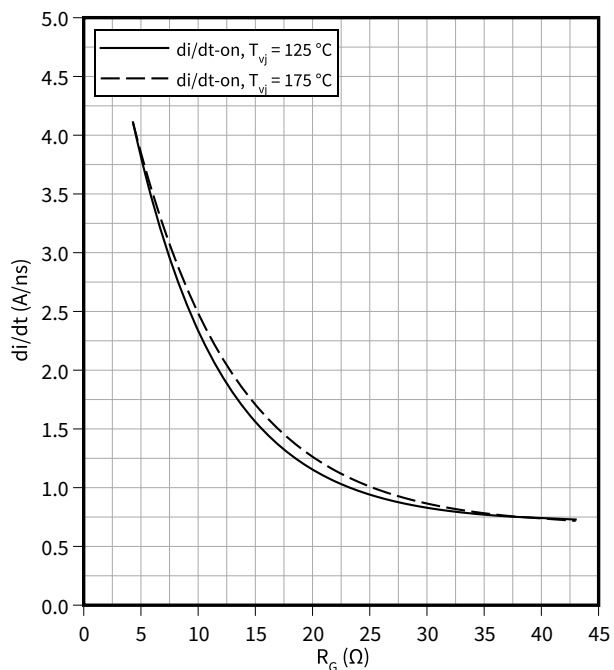
$t = f(I_D)$

 $R_{Goff} = 2.4 \Omega$, $R_{Gon} = 4.3 \Omega$, $V_{DS} = 400 \text{ V}$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$
**Switching times (typical), MOSFET, T2 / T3**

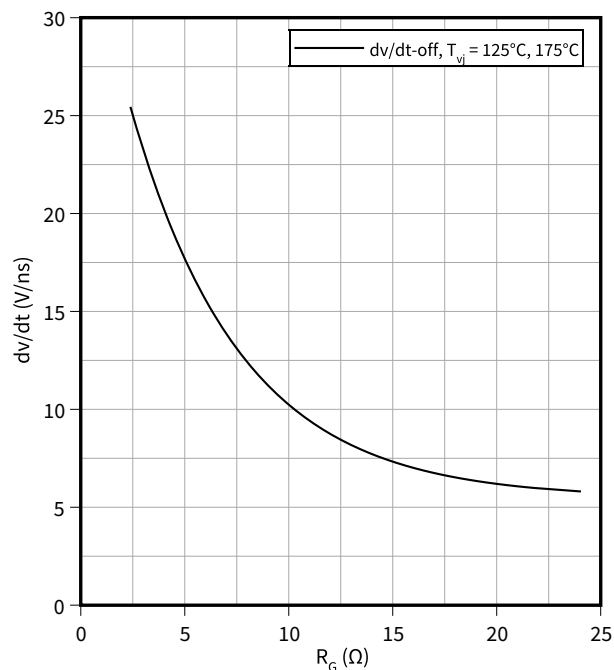
$t = f(R_G)$

 $V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$
**Current slope (typical), MOSFET, T2 / T3**

$di/dt = f(R_G)$

 $V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $V_{GS} = -3/18 \text{ V}$
**Voltage slope (typical), MOSFET, T2 / T3**

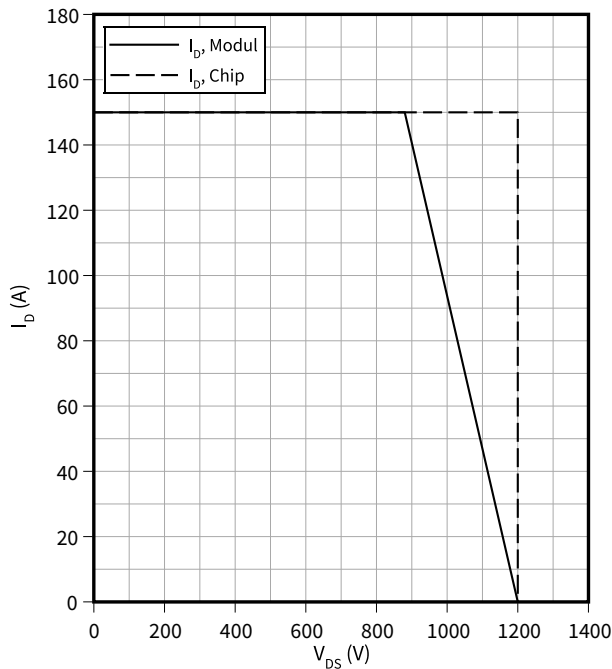
$dv/dt = f(R_G)$

 $V_{DS} = 400 \text{ V}$, $I_D = 75 \text{ A}$, $V_{GS} = -3/18 \text{ V}$


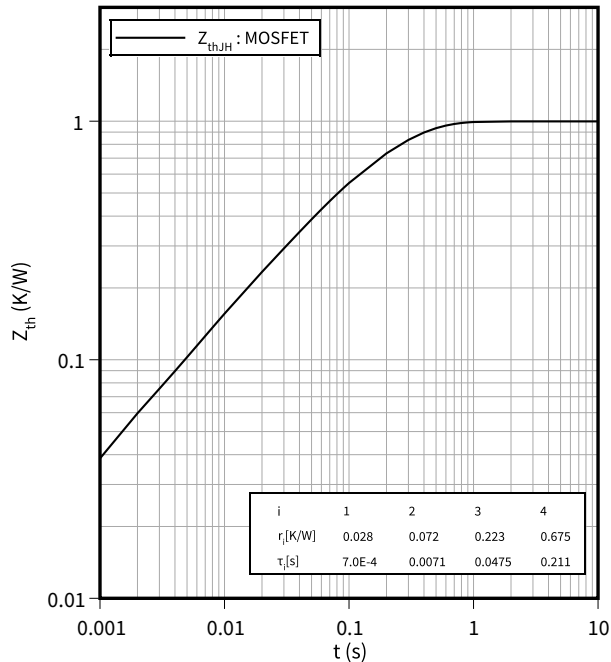
7 Characteristics diagrams

Reverse bias safe operating area (RBSOA), MOSFET, T2 / T3

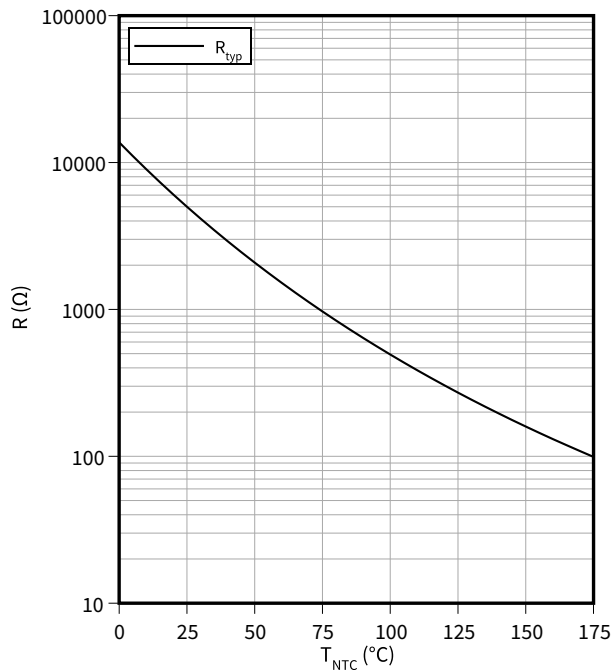
$I_D = f(V_{DS})$
 $R_{Goff} = 2.4 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



Transient thermal impedance , MOSFET, T2 / T3
 $Z_{th} = f(t)$



Temperature characteristic (typical), NTC-Thermistor
 $R = f(T_{NTC})$



8 **Circuit diagram**

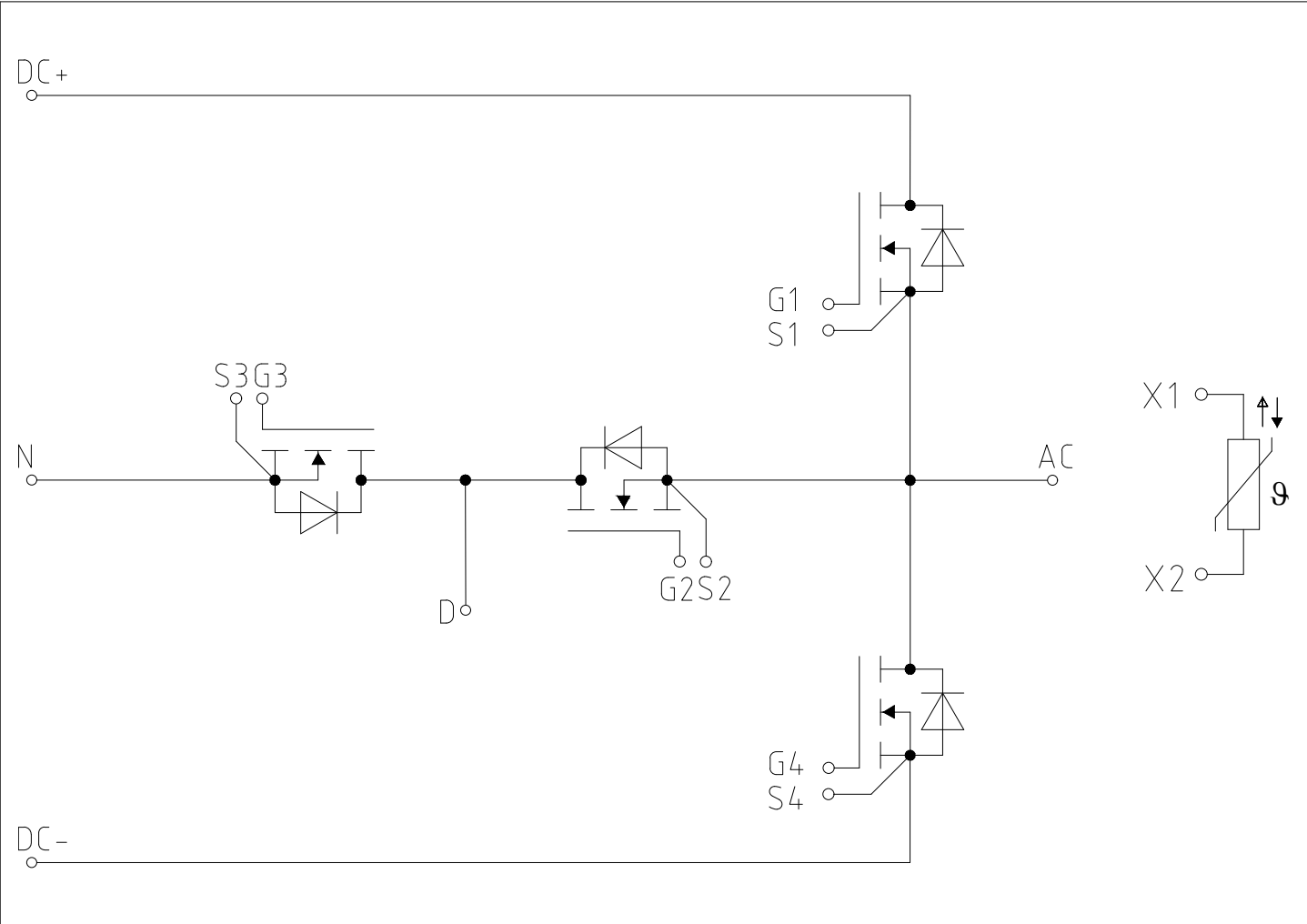


Figure 1

9 Package outlines

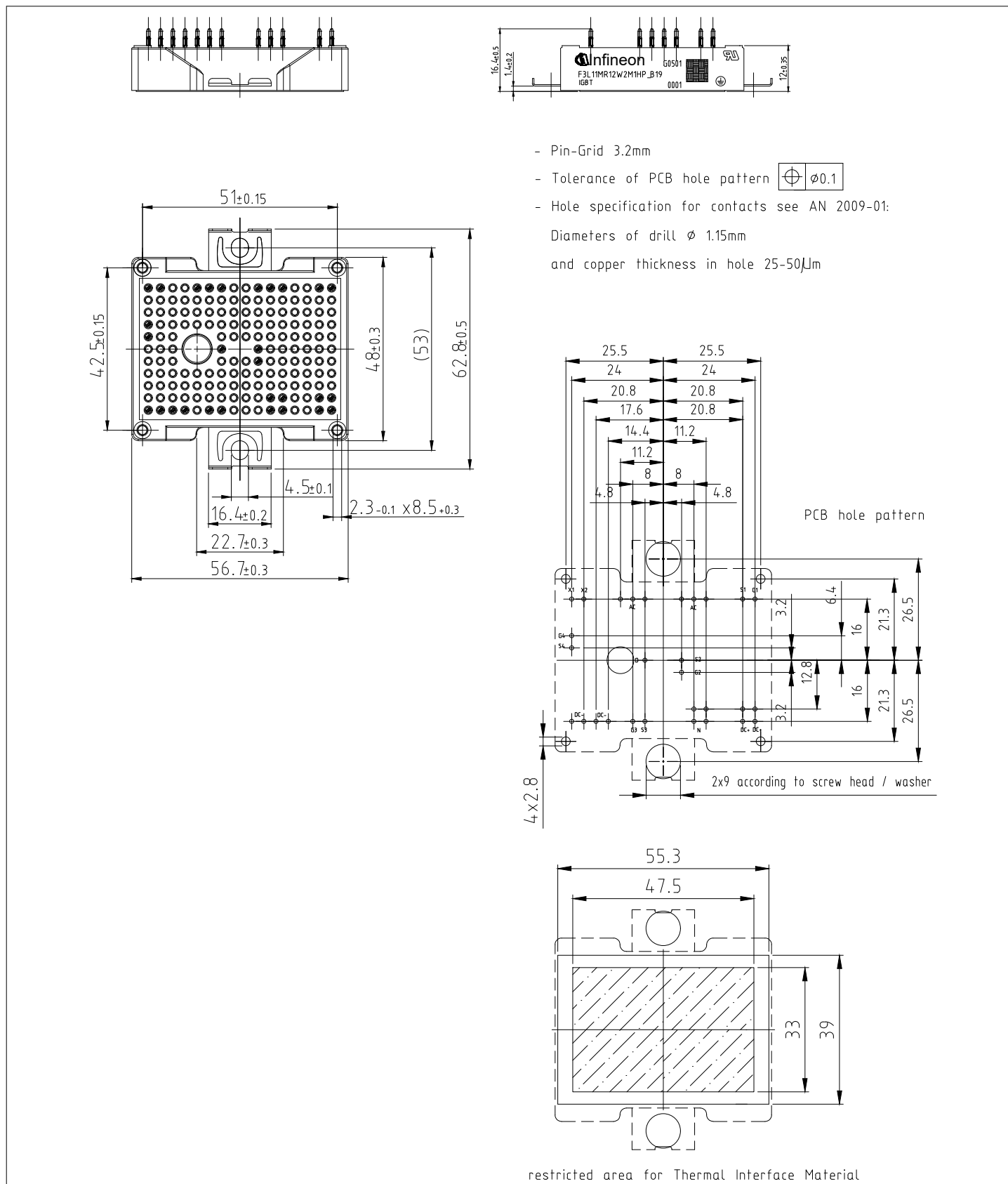


Figure 2

10 Module label code

Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<i>Content</i>	<i>Digit</i>	<i>Example</i>
	Module serial number	1 – 5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 – 21	15
	Date code (production week)	22 – 23	30
Example			
	 71549142846550549911530	 71549142846550549911530	

Figure 3

Revision history

Document revision	Date of release	Description of changes
0.10	2022-02-23	Initial version
0.20	2022-06-01	Preliminary datasheet

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